## Notice of References Cited

Application/Control No. 10/762,390	Applicant(s)/Patent Under Reexamination EBENHOCH, MICHAEL		
Examiner	Art Unit		
David D. Le	3681	Page 1 of 1	

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,874,381 B2	04-2005	Berger et al.	74/335
	В	US-4,033,200	07-1977	Stockton, Thomas R.	475/206
	С	US-5,743,141	04-1998	Forsyth, John R.	74/331
	D	US-5,927,145 A	07-1999	Ahluwalia et al.	74/331
	Е	US-6,067,870 A	05-2000	Fleishman et al.	74/331
	F	US-5,906,132 A	05-1999	Janiszewski, Grzegorz	74/331
	G	US-4,440,037	04-1984	Foxton et al.	74/331 ·
	н	US-4,461,188	07-1984	Fisher, Alan R.	74/330
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 184019 A1	11-2001	World Intellect	BERGER et al.	F16H 61/28
	0	JP 06074305 A	03-1994	Japan	KNOEDEL et al.	F16H 03/08
	Р					
	Q					
	R				** ***	
	s					
	Т					

## **NON-PATENT DOCUMENTS**

	HOIT / HEIT DOOMENTO					
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	٧					
	w					
	x					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.